# **ARTICLE** OPEN Origin of ultrafast growth of monolayer WSe<sub>2</sub> via chemical vapor deposition

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The ultrafast growth of large-area, high-quality WSe<sub>2</sub> domains with a compact triangular morphology has recently been achieved on a gold substrate via chemical vapor deposition. However, the underlying mechanism responsible for ultrafast growth remains elusive. Here, we first analyze growth processes and identify two possible pathways that might achieve ultrafast growth: Path 1, fast edge attachment and ultrafast edge diffusion; Path 2, fast kink nucleation and ultrafast kink propagation. We perform kinetic Monte Carlo simulations and first-principles calculations to assess the viability of these two paths, finding that Path 1 is not viable due to the high edge diffusion barrier calculated from first-principles calculations. Remarkably, Path 2 reproduces all the experimental growth features (domain morphology, domain orientation, and growth rate), and the associated energetic data are consistent with first-principles calculations. The present work unveils the underlying mechanism for the ultrafast growth of WSe<sub>2</sub>, and may provide a new route for the ultrafast growth of other two-dimensional materials.

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# INTRODUCTION

Two-dimensional (2D) materials, such as graphene, boronitrene, phosphorene, transition metal dichalcogenides (TMDs), have attracted a great deal of attention due to their fascinating lattice structures and electronic properties.<sup>1–4</sup> WSe<sub>2</sub>, a member in the TMD family, is a semiconducting material with a sizable band gap, high charge mobility, high on–off ratio, and tunable electronic and optical properties.<sup>5–7</sup> For example, bulk WSe<sub>2</sub> is a p-type semiconductor with an indirect band gap of ~1.2 eV, while monolayer WSe<sub>2</sub> exhibits a direct band gap of ~1.65 eV.<sup>8</sup> In addition, an indirect to direct band gap transition can be achieved in WSe<sub>2</sub> by strain.<sup>9</sup> In particular, the carrier mobility in WSe<sub>2</sub> recently obtained by epitaxy growth is up to 143 cm<sup>2</sup>/(V s),<sup>10</sup> which is remarkably higher than that in other TMDs.<sup>11–13</sup> Therefore, WSe<sub>2</sub> is a promising semiconducting 2D material suitable for ultrafast electronics and optoelectronics.

To realize such applications, fast and mass synthesis of largearea, high-quality 2D WSe<sub>2</sub> is essential. Synthesis of 2D WSe<sub>2</sub> can be achieved by mechanical exfoliation,<sup>14,15</sup> liquid exfoliation,<sup>16–18</sup> and chemical vapor deposition (CVD).<sup>10–13</sup> Among them, CVD has the advantage of the controllable growth of large-area 2D TMDs with the specific lattice structures and the targeted number of layers.<sup>10–13,19,20</sup> Besides that, CVD is also convenient for synthesizing intra-layer junctions between various 2D TMDs, which may have novel applications in electronics and optoelectronics.<sup>21,22</sup>

One of the challenges in the CVD growth of 2D TMDs is the low growth rate.<sup>19–26</sup> It was shown that even by increasing the feedstock concentration or using a gas-phase promoter, the growth rate was still low, often <0.5  $\mu$ m/s on nonmetal substrates.<sup>25,26</sup> This is in sharp contrast to graphene, whose growth rate can reach up to 60  $\mu$ m/s on Cu foil with the assistance

of oxygen atoms.<sup>27–29</sup> Artyukhov et al.<sup>30</sup> proposed that the growth rate of graphene was mainly determined by the kink nucleation because the kink nucleation had a considerable energy barrier to overcome while the kink propagation only had a small energy barrier (which might even fully vanish if the feedstock and catalyst provide carbon in the dimer form). A similar kink-nucleationpropagation mechanism was also revealed in the growth of hexagonal boron nitride.<sup>31</sup> Since chalcogenide atoms are able to etch metal substrates, few metal surfaces are suitable for the epitaxial growth of TMDs. Although Au surfaces were used to grow monolayer  $MoS_2^{11,32}$  and  $WS_{2\prime}^{12,13}$  the growth rates were generally low (<0.7 µm/s). Recently, a surprising breakthrough has been made by Gao et al.<sup>10</sup> in the growth of monolayer WSe<sub>2</sub> on Au (111) by CVD. Remarkably, they have been able to achieve ultrafast growth rates of ~8.3 µm/s at 800 °C and ~26 µm/s at 950 °C. In addition, the grown WSe<sub>2</sub> domains took a regular triangular shape with compact edges, and most importantly, they were of high quality. These features are distinctively different from other 2D materials with similar CVD growth conditions.<sup>27-29</sup>

We note that significant theoretical efforts have been made to understand the growth of graphene.<sup>27–30,33–45</sup> However, only a few theoretical studies have been performed to understand the growth behavior of TMDs due to their complex compound structures.<sup>46–52</sup> Recently, kinetic Monte Carlo (kMC) simulations have also been employed to examine the growth processes of TMDs.<sup>50–52</sup> However, the growth rates that were obtained for compact triangular domains at 1273 K (~10<sup>-6</sup> µm/s,<sup>50</sup> ~10<sup>-5</sup> µm/s,<sup>51</sup> ~10<sup>-4</sup> µm/s<sup>52</sup>) were much lower than that obtained by Gao et al.<sup>10</sup> (26 µm/s). So far, the underlying growth mechanism for the ultrafast growth of regular triangular WSe<sub>2</sub> domains with compact edges remains elusive.

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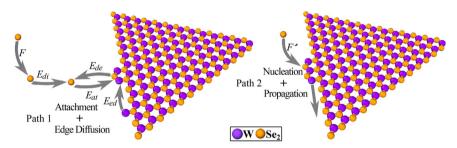
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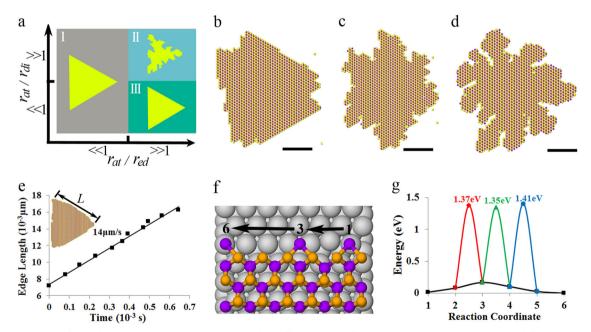
In this work, we aim to unveil the origin of the ultrafast growth of triangular WSe<sub>2</sub> domains with compact edges on Au surface by combining first-principles calculations and kMC simulations. First, we analyze the growth processes and identify possible paths that are potentially viable to realize the ultrafast growth. Our analysis shows that there are two possible paths, that is, Path 1: fast edge attachment and ultrafast edge diffusion, and Path 2: fast kink nucleation and ultrafast kink propagation along the edge. Our results show that Path 1 is not viable due to the high diffusion energy barrier along the edges calculated from our first-principles calculations. For Path 2, however, our kMC simulation results for the growth morphology and growth rate for a wide range of deposition fluxes and temperatures agree well with the experiments. In addition, the used energetic data are consistent with first-principles calculation results. Hence, our study here not only unveils the origin of the ultrafast growth mechanism for WSe<sub>2</sub>, but also potentially presents a novel route to achieve ultrafast growth of other TMDs with large size, compact shape, and high quality.

In Gao et al. experiment,<sup>10</sup> atomic force microscopy measurements showed that the WSe<sub>2</sub> domain had a uniform thickness of ~0.75 nm and average surface roughness of ~0.3 nm. The small

roughness was due to the different thermal coefficient between WSe<sub>2</sub> and Au. Moreover, the Raman spectra taken from 20 random positions showed the same feature in terms of peak position and intensity. All these results indicated that the ultrafast grown WSe<sub>2</sub> domains on Au were uniform monolayers. Based on these experimental observations, we constructed our 2D model to unveil the underlying mechanism on the ultrafast growth of monolayer. The following six dominant events are considered (see the schematic in Fig. 1): (1) deposition of atoms to substrate surface (surface deposition, F), (2) deposition of atoms at domain edge (edge deposition, F'), (3) diffusion of adatoms on substrate surface (surface diffusion,  $E_{di}$ ), (4) attachment of adatoms to domain edge (attachment,  $E_{at}$ ), (5) detachment from domain edge (detachment,  $E_{de}$ ), and (6) diffusion of atoms along domain edge (edge diffusion,  $E_{ed}$ ). It is well-known that the domain morphology and growth rate are primarily governed by the rates of surface diffusion  $(r_{di})$ , attachment  $(r_{at})$ , and edge diffusion  $(r_{ed})$ , which are in turn determined by their energetics  $(E_{di}, E_{at}, E_{de}, E_{ed})^{37}$  and the growth parameters (F, F', T),<sup>42</sup> where T is the growth temperature. A diagram classifying the growth conditions of WSe<sub>2</sub> based on their occurrence rates is shown in Fig. 2a. A key factor that



**Fig. 1** Schematic of the two possible paths for the ultrafast growth of triangular WSe<sub>2</sub> domains. The purple and orange spheres denote W and Se atoms, respectively. *F* and *F'* represent the deposition fluxes for the surface deposition and edge deposition, correspondingly.  $E_{di}$ ,  $E_{der}$ , and  $E_{ed}$  represent the energy barriers for the surface diffusion, attachment, detachment, and edge diffusion processes, respectively. Path 1: fast attachment and ultrafast edge diffusion (left panel), and Path 2: fast kink nucleation and ultrafast kink nucleation (right panel)



**Fig. 2** a Diagram classifying the growth conditions based on the different ratio of attachment rate  $(r_{at})$  to the edge diffusion rate  $(r_{ed})$  and to the surface diffusion rate  $(r_{di})$ . Domain morphologies at 800 °C with **b**  $E_{ed} = 0.5$  eV, **c**  $E_{ed} = 1.0$  eV, and **d**  $E_{ed} = 1.5$  eV, respectively, at  $F_S = 2.0 \times 10^{-2}$  ML/s and  $F_W = 1.8 \times 10^{-2}$  ML/s. **b**-**d** Scale bar: 10*a* (*a* = 0.332 nm). **e** Growth rate of the edge length as a function of time at 800 °C with  $E_{ed} = 0.5$  eV. **f** Schematic illustration of the six energetically favorable sites for in-plane diffusion of W atom along the Se-terminated zigzag edge. Purple, orange, and gray spheres represent W, Se, and Au atoms, respectively. **g** The energy barriers for edge diffusion obtained from first-principles calculations: red: site 2 to site 3, green: site 3 to site 4, and blue: site 4 to site 5

controls the domain morphology is the relative dominance between attachment rate  $(r_{at})$  and edge diffusion rate  $(r_{ed})$ . When  $r_{at}/r_{ed} \ll 1$ , the domain grows in the thermodynamic regime, in which a regular triangular shape with low-energy edges can be maintained due to the fast edge diffusion rate and relatively low attachment rate. Hence, it is possible to achieve the ultrafast growth of WSe<sub>2</sub> domain with a regular triangular shape by a fast attachment rate and an even faster edge diffusion rate (i.e., Path 1 as shown in Fig. 1).

When  $r_{at}/r_{ed} \gg 1$ , the domain grows in the kinetic regime, in which the domain morphology is governed by  $r_{at}/r_{di}$ , where  $r_{di}$  is the surface diffusion rate. When  $r_{at}/r_{di} \ll 1$ , the fast surface diffusion rate is able to assist the attachment of adatoms to the most energetically favorable sites. In this scenario, a complete compact shape could also be achieved. Both the fast kink nucleation and propagation could be completed guickly by the fast attachment of adatoms from substrate or vapor. Clearly, if the kink nucleation rate is fast and the kink propagation is even faster along the edges, it is also possible to achieve the ultrafast growth of WSe<sub>2</sub> domain with a regular triangular shape (i.e., Path 2 as shown in Fig. 1). This mechanism has been proposed to explain the growth of graphene<sup>30</sup> and hexagonal boron nitride.<sup>31</sup> When  $r_{at}/r_{di} \gg 1$ , however, the growth is in the diffusion-limited regime, in which the domain morphology becomes dendrite or fractal. In this regime, it is not possible to achieve the regular triangular shape. The term "ultrafast" was proposed in Gao et al. experimental work.<sup>10</sup> In their work, they achieved a growth rate of  $26 \,\mu$ m/s, which was 2-3 orders of magnitude faster than previous studies.  $^{19-26}$  To achieve this ultrafast growth rate of 26  $\mu\text{m/s},$ together with triangular domains with compact edges, the edge attachment to form kink should be fast. In addition, the edge diffusion to the kink or kink propagation should be even faster. Based on our first-principles calculations and kMC simulations, we are able to give more quantitative descriptions to terms "fast" and "ultrafast": If the energy barrier for an event is ~0.5 eV (for example, the kink formation with an energy barrier of 0.55 eV), we call it "fast". On the other hand, if the energy barrier for an event is much lower than 0.5 eV (for example, the surface diffusion of adatom with an energy barrier of 0.36 eV), we call it "ultrafast".

Our above analyses of growth mechanisms suggest two possible paths that are able to achieve the ultrafast growth of  $WSe_2$  domain with a regular triangular shape, that is, Path 1: a fast attachment and an ultrafast edge diffusion along the domain edges, and Path 2: a fast kink nucleation and an ultrafast kink propagation rate along the domain edges. These two paths are schematically illustrated in Fig. 1. In the following, we perform first-principles calculations and kMC simulations to assess the viability of the two possible paths.

# RESULTS

# Path 1: fast attachment and ultrafast edge diffusion

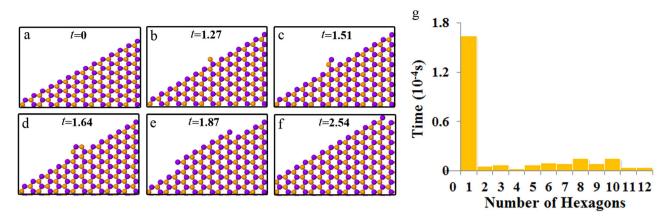
To find out the deposition flux for Se dimer ( $F_S$ ) and W atom ( $F_W$ ) corresponding to Gao et al.<sup>10</sup> experimental growth conditions, we performed a sequence of kMC simulations by varying  $F_S$  and  $F_W$ . We found that when  $F_S = 2.0 \times 10^{-2}$  and  $F_W = 1.8 \times 10^{-2}$  ML/s, the growth rate of the WSe<sub>2</sub> domain is ~14 µm/s (c.f. Fig. 2e), which is consistent with that obtained by Gao et al.<sup>10</sup> (8.3–26 µm/s). The kMC simulated domain morphologies at three different energy barriers for edge diffusion, that is,  $E_{ed} = 0.5$ , 1.0, and 1.5 eV are shown in Fig. 2b–d, respectively, with the same flux and coverage. Their morphological evolutions are shown in Supplementary Movies 1–3. It is seen that a compact triangular shape is achieved when  $E_{ed} = 0.5$  eV (c.f. Fig. 2b) due to the fast diffusion of attached atoms capable to reach the global energetically favorable sites along the edges, which is also evidenced by the evolution of the domain morphology shown in Supplementary Movie 1. With

increasing energy barrier for edge diffusion, however, the domain morphology becomes gradually more dendritic and fractal. This trend is clearly seen from Fig. 2c, d, and Supplementary Movies 2– 3. The underlying reason for the trend is that when the energy barrier for the edge diffusion increases, for example, to 1.0 eV, the edge diffusion of the attached atoms is limited and they can only diffuse to local energetically favorable sites, leading to the rough edge morphologies. When the edge diffusion barrier is further increased to 1.5 eV, diffusion of the attached atoms to the energetically favorable sites becomes even less probable, resulting in a dendritic and fractal shape, which falls into the kinetic regime. Clearly, by increasing the diffusion energy barrier along the edges, there is a transition in the growth mode from the thermodynamic regime (compact triangular shape) to the kinetic regime (dendritic and fractal shape).

Our above kMC simulations clearly showed that Path 1 is able to achieve a triangular WSe<sub>2</sub> domain with ultrafast growth rate under the condition that the energy barrier for the edge diffusion must be low (≤0.5 eV). To validate this necessary condition, we performed first-principles calculations on the energy barriers of edge diffusion. First, we calculated the energies of W atom via different in-plane sites (marked by 1–6 in Fig. 2f) and out-of-plane sites (marked by I and II in Figure S3b in Supplementary Information) along the Se-terminated zigzag edge. Figure 2g shows the energies of W atom at the six in-plane steps. It is seen that the diffusion of W atom from site 1 to site 2 or from site 5 to 6 is easier than that from site 2 to site 3, site 3 to site 4, and site 4 to site 5 due to the lower energies of site 1 and site 6 (c.f. black squares in Fig. 2g). Therefore, the diffusion of W atom from site 2 to site 3 (c.f. red curve in Fig. 2g), site 3 to site 4 (c.f. green curve in Fig. 2g), and site 4 to site 5 (c.f. blue curve in Fig. 2g) were further calculated to obtain their diffusion energy barriers. It is seen from Fig. 2g that the energy barriers for the edge diffusion of W along Se-terminated edge are ~1.4 eV, which is significantly higher than 0.5 eV. We have also evaluated the energy barrier for Se atom diffusion along the W-terminated zigzag edge by first-principles calculations. We found that the W-terminated zigzag edge underwent reconstruction (c.f. Figure S3d), exhibiting substantial inward displacements of all the first-row W atoms and outward displacements of half of the second-row Se atoms. The same edge reconstruction has also been reported by Cui et al.<sup>53</sup> The minimum energy path for the diffusion of a Se atom along the reconstructed W-terminated zigzag edge is plotted in Figure S3e, and the schematic structures corresponding to the different states are shown in Figure S3f. The forward (from IS to FS in Figure S3f) diffusion barrier is 1.08 eV, while the backward one (from FS to IS in Figure S3f) is 2.94 eV, indicating the high energy barriers for Se diffusion along the reconstructed W-terminated zigzag edge. Such high energy barriers for the edge diffusion of both W and Se suggest that Path 1 is not energetically favorable and thus cannot be the underlying mechanism for the ultrafast growth of highquality triangular WSe<sub>2</sub> domain observed experimentally.<sup>10</sup>

#### Path 2: fast kink nucleation and ultrafast kink propagation

In Path 2, there are two major steps: the kink nucleation and kink propagation. Since compact edges were observed experimentally,<sup>10</sup> this suggests that the growth rate is likely to be limited by the kink formation, rather than kink propagation. The energy barriers for the kink nucleation are the same as the attachment processes (0.55 eV for zigzag attachment and 0.32 eV for kink formation.<sup>10</sup>). A couple of interesting questions arise: why can the kink propagation be ultrafast? During the kink propagation, where are the feeding atoms coming from? To answer these questions, we carried out detailed analyses and further kMC simulations. Previous first-principles calculations<sup>10</sup> showed that the energy reduction of Se atom from the vapor to deposit to an existing kink site at the growth front is 2.5 eV and the energy reduction of Se



**Fig. 3 a–f** Kink nucleation and propagation processes. Purple and orange spheres represent the W and Se, respectively. **g** The estimated formation times for each hexagon during the kink nucleation and propagation at the W-terminated zigzag edge. Time unit:  $10^{-4}$  s

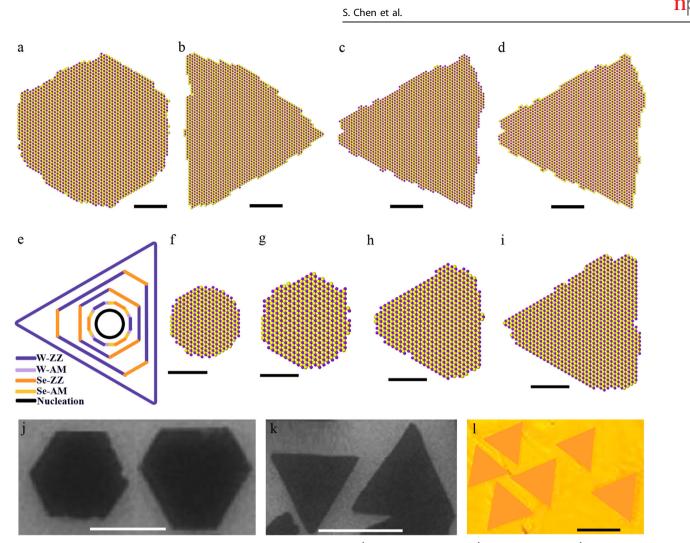
atom from the substrate to attach an existing kink site at the growth front is 1.0 eV. Moreover, the deposition process is barrierless while the attachment of Se atom on the substrate to the kink encounters a barrier of 0.32 eV from first-principles calculations.<sup>10</sup> Therefore, the deposition of atoms directly to the kinks at the edges from the vapor is energetically more favorable than the attachment from the substrate surface. Hence, the ultrafast kink propagation is due to the large energy reduction in the attachment of Se atoms to the existing kink sites, particularly from the vapor.

In Gao et al.<sup>10</sup> experiments, the deposition of Se is the ratelimiting process, and the growth rate increases with increasing the feeding rate of Se. Therefore, the overall flux of W is larger than that of Se, and most domains are of W-terminated zigzag edges. Using the energy barriers from first-principle calculations,<sup>10</sup> we performed kMC simulations on the growth front of W-terminated zigzag edges with  $F_W = 2.5 \times 10^{-4} \text{ ML/s}, F_S = 0.5 \times 10^{-4} \text{ ML/s},$ whose growth rate agrees well with Gao et al.<sup>10</sup> experiments. Snapshots in the growth process at the W-terminated zigzag edge are shown in Fig. 3a-f. Initially, Se dimers are attached (from the substrate) or deposited (from the vapor) to the W-terminated zigzag edge (c.f. Fig. 3a, b). For a larger flux of W, W atoms are attached or deposited to bond Se atoms at the edge (c.f. Fig. 3c), generating energetically favorable armchair sites of Se to form a kink. The sites of Se are then occupied by either a diffusing Se dimer or a Se dimer from the vapor phase, resulting in the formation of a hexagonal kink (c.f. Fig. 3d). Then, W atoms will attach, diffuse, or deposit to bond to the kink due to the large flux, bringing in new energetically favorable armchair sites of Se (c.f. Fig. 3e). Finally, these sites of Se are quickly occupied by atoms due to the absence of energy barriers. This repeating process induces an ultrafast propagation of the hexagonal kink (c.f. Fig. 3f). We have also estimated the time to form each hexagon during the formation and propagation of a kink and the results are shown in Fig. 3g. It is seen the time to form the first hexagonal kink is  $\sim 1.64 \times 10^{-4}$  s, which is the longest. The formation times for subsequent hexagons are much shorter, in the range of (0.1 imes $10^{-4}$  s,  $0.2 \times 10^{-4}$  s). The above simulations demonstrate that once a hexagonal kink is nucleated at the zigzag edge, it will guickly propagate along the edge. The growth rate is limited by the kink nucleation rate, which is related to the attachment rate or the edge deposition from the vapor phase.

Furthermore, Gao et al.<sup>10</sup> observed triangular domains with two opposite orientations in their experiments (c.f. Fig. 4). Interestingly, Najmaei et al.<sup>54</sup> experimentally not only observed triangular domains with opposite orientations, but also hexagonal domains of MoS<sub>2</sub> at different concentrations of sulfur (c.f. Fig. 4j, k). Their experiments showed that when the sulfur concentration was low, hexagonal domains appeared (c.f. Fig. 4j); while when the sulfur concentration was increased, triangular domains with opposite orientations appeared on the same substrate surfaces (c.f. Fig. 4k). The underlying reason for these different domain shapes and orientations is not yet fully understood.

To understand the formation of these different domain shapes, we performed kMC simulations to investigate the growth of the WSe<sub>2</sub> domain at the three different deposition fluxes of W atoms and Se dimers, that is,  $F_W = F_S$ ,  $F_W < F_S$ , and  $F_W > F_S$ . The domain morphologies for these three different growth conditions are shown in Fig. 4a-c, respectively. It is seen that when the deposition fluxes of W atoms and Se dimers are identical ( $F_W =$  $F_{\rm S} = 2.5 \times 10^{-4}$  ML/s), the domain morphology exhibits a compact hexagonal shape (c.f. Fig. 4a and Supplementary Movie 4). When the deposition flux of Se dimers is larger than that of W atoms ( $F_W$ )  $= 0.5 \times 10^{-4}$  ML/s,  $F_s = 2.5 \times 10^{-4}$  ML/s), the domain becomes a triangular shape with Se-terminated zigzag edges as shown in Fig. 4b and Supplementary Movie 5. When the deposition flux of W atoms is larger than that of Se dimers ( $F_W = 2.5 \times 10^{-4}$  ML/s,  $F_S$  $= 0.5 \times 10^{-4}$  ML/s), the domain turns into an opposite-orientated triangular shape with W-terminated zigzag edges (c.f. Fig. 4c and Supplementary Movie 6). In Gao et al. experiment,<sup>10</sup> triangular domains with both W-terminated edge and Se-terminated edge were observed. Therefore, the local fluctuations of W and Se fluxes may be a possible mechanism for observed opposite-oriented triangles. However, the flux at which the triangles grow next to each other may not be very different for W and Se. In that case, the opposite-oriented triangles could be formed by oppositeorientated nuclei with the same type or different types of edges. To verify this, we performed KMC simulations with oppositeorientated nuclei (c.f. Fig. 4b-d). The simulation results suggest that indeed the opposite-orientated domains with the same type or different types of edges can be achieved. Hence, our work suggests two possible approaches to achieve opposite-oriented triangles: (1) different fluxes for W and Se (Fig. 4b vs 4c), and (2) opposite-orientated nuclei (Fig. 4b vs 4d).

The formation of these hexagonal and triangular domains from the initial circular shape can be well understood by using the kinetic Wulff construction theory (c.f. Fig. 4e). Since the domain morphology is governed by the kinetics of attachment and detachment of atoms to the edges, during the growth process, the fast-growing edges eventually lose out to those with the slowgrowing edges. During the initial growth, we found that the growth rates of W-terminated and Se-terminated zigzag edges are nearly equal due to the small size of nucleus, which are slower than the armchair edges. Therefore, the domain shape will transform from a circular shape to a hexagonal shape with only zigzag edges. As the domain grows continuously, the zigzag edges become sensitive to the deposition fluxes of Se dimers and W atoms. When the growth rate of Se-terminated zigzag edge is

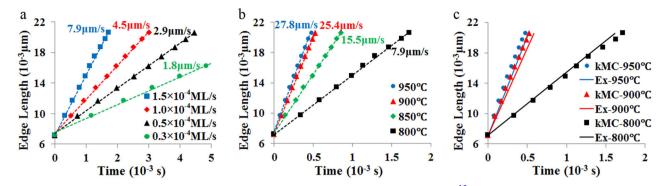


**Fig. 4** Snapshots of the WSe<sub>2</sub> domain at 800 °C when **a**  $F_W = F_S = 2.5 \times 10^{-4}$  ML/s, **b**  $F_W = 0.5 \times 10^{-4}$  ML/s,  $F_S = 2.5 \times 10^{-4}$  ML/s, **c**  $F_W = 2.5 \times 10^{-4}$  ML/s,  $F_S = 0.5 \times 10^{-4}$  ML/s, and **d**  $F_W = 0.5 \times 10^{-4}$  ML/s,  $F_S = 2.5 \times 10^{-4}$  ML/s. (**a**-**c**) have the same-orientated nuclei, while (**d**) has an opposite-orientated nucleus with (**a**-**c**). **a**-**d** Scale bar: 10*a* (*a* = 0.332 nm). **e** Illustration of the kinetic Wulff construction theory during the domain growth. **f**-**i** Snapshots showing the shape evolution from the initial circular shape to the final triangular shape with W-terminated zigzag edges. W atoms are marked by purple spheres. **f**-**i** Scale bar: 10*a* (*a* = 0.332 nm). Scanning electron microscopy images of MoS<sub>2</sub> at **j** lower sulfur concentrations and **k** higher sulfur concentrations. **j**, **k** Scale bar: 10 µm. **j**, **k** Reproduced from ref. <sup>54</sup> with permission from Springer Nature. **I** Scanning electron microscopy images of WSe<sub>2</sub> in Gao et al. ultrafast growth. **I** Scale bar: 100 µm. **I** Reproduced from ref. <sup>10</sup> with permission from John Wiley and Sons

larger than that of W-terminated zigzag edge, the domain will transform from a hexagonal shape with mixed W-terminated and Se-terminated zigzag edges to a triangular shape with only Wterminated zigzag edges. Conversely, when the growth rate of Seterminated zigzag edge is smaller than that of W-terminated zigzag edge, the domain morphology will transform from the hexagonal shape with mixed W-terminated and Se-terminated zigzag edges to a triangular shape with only Se-terminated zigzag edges, giving rise to two opposite-oriented triangular shapes. Figure 4f-i shows the evolution of domain morphology during the growth with a larger deposition flux of W. It is seen clearly that the domain morphology transforms from a circular shape to a hexagonal shape initially (c.f. Fig. 4f, g). After that, the domain morphology transforms from a hexagonal shape to a triangular shape with only W-terminated zigzag edges (c.f. Fig. 4g-i), which agrees well with the kinetic Wulff construction theory (c.f. Fig. 4e). It is noted that there were two opposite orientations of triangular domains in experiments.<sup>10,54</sup> The underlying reason could be due to the fluctuations in fluxes at different local regions on the substrate surfaces. In Gao et al. experiments, since the W flux is

higher than Se flux, the triangular domains with W-terminated edges are dominant (c.f. Fig. 4I). In some regions, however, the flux of W atoms could be smaller than that of Se atoms due to the flux fluctuations, which might result in domains with Se-terminated zigzag edges. Similarly, the triangular domains with opposite orientations observed in Najmaei et al. experiments<sup>54</sup> might also be formed due to the fluctuations in local fluxes of Mo and S atoms. Of course, the opposite-oriented triangles could also be formed by opposite-orientated nuclei, and these triangles might have the same type or different types of edges.

The fast (~3 µm/s) and ultrafast growth (~60 µm/s) of graphene has already been reported.<sup>27–29</sup> These studies revealed that the supply of oxygen decreased the graphene nucleation density by passivating Cu surface active sites<sup>29</sup> and accelerated graphene domain growth by lowering the energy barrier to the decomposition of carbon feedstock.<sup>28</sup> The graphene domain shape in ultrafast growth rate was often dendrite, hexagonal, or circular,<sup>28,29</sup> but not triangle with compact edges. For the ultrafast growth of WSe<sub>2</sub>, although the growth rate was similar (~26 µm/s),<sup>10</sup> the domains are of a triangular shape with compact S. Chen et al.



**Fig. 5** Comparison of growth rate between our kMC simulations and Gao et al. experiments.<sup>10</sup> **a** Comparison of growth rate at different deposition fluxes:  $F_W = 2.5 \times 10^{-4}$  ML/s,  $U_S = 1.5 \times 10^{-4}$ ,  $1.0 \times 10^{-4}$ ,  $0.5 \times 10^{-4}$ , and  $0.3 \times 10^{-4}$  ML/s. **b** Comparison of growth rate at growth temperatures: 800, 850, 900, and 950 °C. **c** Comparison of growth rate at different deposition fluxes and temperatures: 800 °C ( $F_W = 2.5 \times 10^{-4}$  ML/s,  $F_S = 1.5 \times 10^{-4}$  ML/s), and 900 °C ( $F_W = 2.5 \times 10^{-4}$  ML/s,  $F_S = 1.5 \times 10^{-4}$  ML/s), and 900 °C ( $F_W = 2.5 \times 10^{-4}$  ML/s),  $F_S = 1.5 \times 10^{-4}$  ML/s),  $F_S = 0.5 \times 10^{-4}$  ML/s) between kMC simulation results (7.9, 25.4, and 27.8 µm/s) and the experimental results (8.3, 23, and 26 µm/s)<sup>10</sup>

edges, indicating a different underlying mechanism from graphene. Our work shows that the ultrafast growth and compact edges of  $WSe_2$  domain result from the fast kink nucleation and ultrafast kink propagation. The fast kink nucleation is due to the lower energy barrier of edge attachment, and the ultrafast kink propagation comes from the ultrafast surface diffusion or direct deposition of W and Se adatoms to the growth front.

#### Growth rates varying with fluxes and temperatures

In the following, we would like to compare our kMC simulation results with the experimental results obtained by Gao et al.<sup>10</sup> under different growth conditions. We note that Gao et al.<sup>10</sup> reported a drastic increase in the growth rate from 0.26 to 8.3 µm/ s with increasing the feeding rate of Se from 1.4 to 65 standard cubic centimeter per minute (sccm) at 800 °C. Our simulation results show almost the same growth rates from 1.8 to 7.9 µm/s as the deposition flux of Se dimer increases (by increasing  $F_S$  from  $0.3 \times 10^{-4}$  ML/s to  $1.5 \times 10^{-4}$  ML/s at a constant  $F_W = 2.5 \times 10^{-4}$  ML/s) (c.f. Fig. 5a). Gao et al.<sup>10</sup> also reported a sharp increase in the growth rate from 8.3 to 26 µm/s by increasing the temperature from 800 to 950 °C. The growth rate in our simulations increases from 7.9 to 27.8  $\mu$ m/s with increasing the temperature from 800 to 950 °C (c.f. Fig. 5b). In addition, the growth rates at different deposition fluxes and temperatures from both our kMC simulation results (800 °C: 7.9 µm/s, 900 °C: 25.4 µm/s, and 950 °C: 27.8 µm/s) and the experimental results (800 °C: 8.3 µm/s, 900 °C: 23 µm/s, and 950 °C: 26 µm/s) are shown in Fig. 5c, and a good agreement is evident. These comparisons in the growth rate between the simulations and experiments indicate that there is an almost quantitative agreement between our kMC simulations and the experimental results.

## DISCUSSION

By performing growth process analysis, kMC simulations and firstprinciples calculations, we investigated the underlying mechanism for the ultrafast growth of regular triangular WSe<sub>2</sub> monolayer with compact edges on Au(111) via CVD. Our growth process analysis suggested two possible paths leading to the ultrafast growth of compact triangular domain, that is, Path 1: fast edge attachment and ultrafast edge diffusion, and Path 2: fast kink nucleation and ultrafast kink propagation along the edge. Based on our DFT calculations and comparison with the experimental growth rate and morphology, we ruled out Path 1 due to the high diffusion barriers along the domain edges. Our kMC simulations suggested that Path 2 is the underlying mechanism responsible for the ultrafast growth observed in Gao et al.<sup>10</sup> experiments since the simulated domain morphology, domain orientation, and growth

rate are in agreement with the experimental results under wide ranges of deposition flux and temperature. We further showed that in Path 2, kink nucleation is clearly the limiting factor. Hence, the growth rate can be further tuned by controlling the kink nucleation rate, which is in turn controlled by the deposition of atoms from the vapor or by the attachment of the diffusing atoms on the substrate. In addition, the domain orientation can also be regulated by controlling the relative dominance of deposition species. Our work reveals that the fast kink nucleation and ultrafast kink propagation are the underlying mechanisms responsible for the ultrafast growth of WSe<sub>2</sub> domains. The fast kink nucleation is due to the low energy barrier of edge attachment. The ultrafast kink propagation results either from the even lower energy barrier of surface diffusion of adatoms or their direct deposition from vapor to the growth front. This mechanism can be potentially extended to other 2D materials. For example, the ultrafast growth of other TMDs may also be achievable if a substrate is able to greatly enhance the surface diffusion of adatoms or promote their direct deposition from vapor to the growth front.

# METHODS

## Simulation method

Our kMC simulation model is illustrated in Fig. 1, in which 2D hexagonal WSe<sub>2</sub> lattice (lattice constant a = 0.332 nm) is used.<sup>55</sup> An initial circular nucleus of WSe<sub>2</sub> domain with a diameter of 5.3 nm is introduced at the center of the simulation box. All six dominant events discussed above are considered in the model. The energetics for these events was obtained by using first-principles calculations either from lirerature<sup>10</sup> or from our own. To simulate the deposition and diffusion of adatoms on the Au(111) substrate, the substrate surface was mapped into a hexagonal lattice with the same lattice constants of WSe2. As a result, W and Se will deposit or diffuse on these corresponding lattice sites (on-lattice simulation). However, the energetics will follow these on the Au(111) substrate. To simplify the deposition and diffusion processes, we only consider W atoms and Se dimers in our simulations. The dimensions of the kMC simulation box are taken as 28.2 × 32.6 nm<sup>2</sup>. Periodic boundary conditions are taken along the lateral directions. The details of our kMC model and corresponding energetics are given in Supplementary Information.

## DATA AVAILABILITY

The data that support the findings of this study and the code for the strategy proposed in this study are available from the corresponding author upon request.

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## AUTHOR CONTRIBUTIONS

Y.-W.Z. supervised and conceived this project. S.C. established the theoretical models and performed kMC simulations. J.G. did first-principles calculations. B.M.S., G.Z., V.S., and R.H. discussed the results. S.C. wrote the paper. All of the authors commented on the manuscript.

#### ADDITIONAL INFORMATION

**Supplementary information** accompanies the paper on the *npj Computational Materials* website (https://doi.org/10.1038/s41524-019-0167-2).

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